

**Search Notes**

Application/Control No.

10/757,334

Examiner

Igor Kershteyn

Applicant(s)/Patent under  
Reexamination

JAPIKSE ET AL.

Art Unit

3745

**SEARCHED**

Class	Subclass	Date	Examiner
415	1		
	58.4		
	116		
	144		
	145		
	149.1		
	151		
	910		
	914	7/7/2005	I.K.

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted Ninh Nguyen	7/7/2005	I.K.

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner